



EMC TEST REPORT

Report No.: SET2015-05276

Product Name: Smart Phone

FCC ID: QISY538

Model No. : Y538-A1, Y538A1, Y538, HUAWEI Y538-A1, HUAWEI Y538A1
HUAWEI Y538

Applicant: Huawei Technologies Co., Ltd.

Address: Administration Building, Headquarters of Huawei Technologies Co., Ltd., Bantian, Longgang District, Shenzhen, 518129, P.R.C

Received Date: 2015-04-13

Tested Date: 2015-04-13—2015-04-21

Issued by: CCIC Southern Electronic Product Testing (Shenzhen) Co., Ltd.

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Test Report

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Manufacturer : Huawei Technologies Co., Ltd.

Manufacturer Address : Administration Building, Headquarters of Huawei Technologies Co., Ltd., Bantian, Longgang District, Shenzhen, 518129, P.R.C

Test Standards : 47 CFR Part 15 :2014 ,Subpart B

Test Result : PASS

Tested by : Xiaolong Zhang 2015.04.22
Xiaolong Zhang, Test Engineer

Reviewed by : Shuangwen Zhang 2015.04.22
Shuangwen Zhang, Senior Engineer

Approved by : Wu Lian 2015.04.22
Wu Li'an, Manager

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Change History		
Issue	Date	Reason for change
1.0	2015.04.22	First edition



1. GENERAL INFORMATION

1.1 EUT Description

EUT Name : Smart Phone
Serial No..... : URX0115327000284
IMEI No. : 867260020007433
FCC ID..... : QISY538
Trade Name..... : HUAWEI
Brand Name..... : HUAWEI
Hardware Version..... : HL1Y538A1M
Software Version..... : Y538A1V100R001C237B018
Power Supply : Battery
Brand Name: HUAWEI
Model No.: HB474284RBC
Capacitance: 2000 mAh
Rated Voltage: 3.8V
Charge Limit: 4.35V
Serial No.: 1477LCE307
Ancillary Equipment 1 : AC Adapter 1(Charger for Battery)
Brand Name: HUAWEI
Model No.: HW-050100U2W
Rated Input: 100-240V, 50/60Hz ,0.2A
Rated Output: 5V=1.0A
Serial No.:B64623EECT01455
Ancillary Equipment 2 : Data cable(Shielded)
Model No.: LSA00730
Model No.: CD-U0405-1125
Model No.: 130-26416
Model No.: H09-000576

Note1: The EUT is a Smart Phone, the CDMA frequency band is CDMA BC0 (Cell 800) and BC1 (PCS1900) and BC10 (Sec 800). The GSM/GPRS/EDGE frequency band includes GSM850 and GSM900 and DCS1800 and PCS1900. The UMTS frequency band is band II and band V. The LTE frequency band is B25 and B26 and B41. But only GSM850 and GSM1900MHz and CDMA BC0 and CDMA BC1 and CDMA BC10 and WCDMA band II, band V and LTE B25, B26, B41 test data included in this report. The Mobile Phone implements such functions as RF signal receiving/transmitting, CDMA2000 1x /1X EV-DO and LTE/UMTS and GSM/GPRS/EDGE protocol processing, voice, MMS service, GPS, AGPS and WIFI etc. Externally it provides micro SD card interface, earphone port (to provide voice service). It also provides Bluetooth module to synchronize data between a PC and the phone, or to use

the built-in modem of the phone to access the Internet with a PC, or to exchange data with other Bluetooth devices.

*Note 2:*The EUT support the work frequency as below:

Mode		Work Frequency	
		Transmitt Frequency (MHz)	Receive Frequency (MHz)
WCDMA	WCDMA1900	1850-1910	1930-1990
	WCDMA850	824-849	869-894
GSM	PCS1900	1850-1910	1930-1990
	GSM850	824-849	869-894
WiFi	2412-2462		
Bluetooth	2402-2480		
GPS	--	--	1575.42
LTE	Band 25	1850-1915	1930-1995
	Band 26	814-849	859-894
	Band 41	2496-2690	2496-2690
CDMA2000	CELL	824-849	869-894
1x and 1 X	PCS	1850-1910	1930-1990
EV-DO	SEC	816-823.975	861-868.975

*Note 3:*The EUT has six models, the differences between them refer to the statement.

*Note 4:*For a more detailed description, please refer to Specification or User's Manual supplied by the applicant and/or manufacturer.



1.2 Test Standards and Results

The objective of the report is to perform testing according to 47 CFR Part 15 Subpart B 2014:

No.	Identity	Document Title
1	47 CFR Part 15 Subpart B 2014	Radio Frequency Devices

Test detailed items/section required by FCC rules and results are as below:

No.	Section	Description	Result
1	15.107	Conducted Emission	PASS
2	15.109	Radiated Emission	PASS

NOTE:

(1) The EUT has been tested according to 47 CFR Part 15 Subpart B 2014. The test procedure is according to ANSI C63.4:2009.



1.3 Facilities and Accreditations

1.3.1 Facilities

CNAS-Lab Code: L1659

CCIC Southern Electronic Product Testing (Shenzhen) Co., Ltd. CCIC is a third party testing organization accredited by China National Accreditation Service for Conformity Assessment (CNAS) according to ISO/IEC 17025. The accreditation certificate number is L1659. A 12.8*6.8*6.4 (m) fully anechoic chamber was used for the radiated spurious emissions test.

FCC-Registration No.: 406086

CCIC Southern Electronic Product Testing (Shenzhen) Co., Ltd. EMC Laboratory has been registered and fully described in a report filed with the FCC (Federal Communications Commission). The acceptance letter from the FCC is maintained in our files. Registration 406086, valid time is until October 28, 2017.

IC-Registration No.: 11185A-1

CCIC Southern Electronic Product Testing (Shenzhen) Co., Ltd. EMC Laboratory has been registered by Certification and Engineering Bureau of Industry Canada for the performance of radiated measurements with Registration No. 11185A-1 on July. 15, 2013, valid time is until July. 15, 2016.

1.3.2 Test Environment Conditions

During the measurement, the environmental conditions were within the listed ranges:

Temperature (°C):	15°C - 35°C
Relative Humidity (%):	25% -75%
Atmospheric Pressure (kPa):	86kPa-106kPa

1.3.3 Measurement Uncertainty

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in Measurement" (GUM) published by ISO.

Uncertainty of Conducted Emission:	Uc = 3.6 dB (k=2)
Uncertainty of Radiated Emission:	Uc = 4.5 dB (k=2)

2. TEST CONDITIONS SETTING

2.1 Test Peripherals

The following is a listing of the EUT and peripherals utilized during the performance of EMC test:

Description	Manufacturer	Model	Serial No.	FCCID /DOC
Notebook	Lenovo	ThinkPad Edge E431	/	/
Micro SD card	SanDisk	/	/	/
MOUSE	Lenovo	MO32BOA	4449040	DOC

2.2 Test Mode

All the test modes were carried out with the EUT under normal operation, which were shown in this report and defined as below.

Test Mode	
Mode 1	Adapter +Earphone+Camera On+Idle
Mode 2	Adapter +Earphone+Playing+Idle
Mode 3	Adapter+Earphone +Traffic
Mode 4	USB Copy(EUT with PC) +Earphone + Idle

Traffic Mode:

The EUT state is switch on and with Radio Resource Control connection established.

Idle Mode:

The EUT state is switch on But without Radio Resource Control connection established.

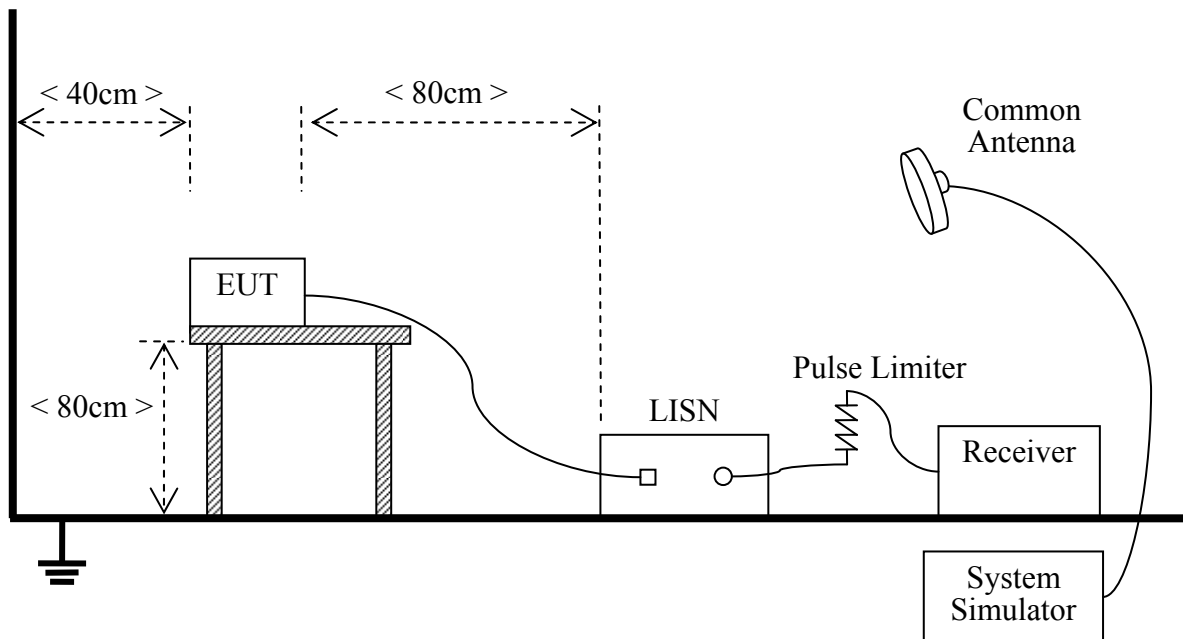
NOTE:

1. There is one kind of accessories with different models, each one should be applied throughout the compliance test respectively, however, only the worst case will be recorded in this report.
2. All test modes are performed, only the worst case is recorded in this report.

2.3 Test Setup and Equipments List

2.3.1 Conducted Emission

A. Test Setup:



The EUT is placed on a 0.8m high insulating table, which stands on the grounded conducting floor, and keeps 0.4m away from the grounded conducting wall. The EUT is connected to the power mains through a LISN which provides 50Ω/50μH of coupling impedance for the measuring instrument. The Common Antenna is used for the call between the EUT and the System Simulator (SS). A Pulse Limiter is used to protect the measuring instrument. The factors of the whole test system are calibrated to correct the reading.

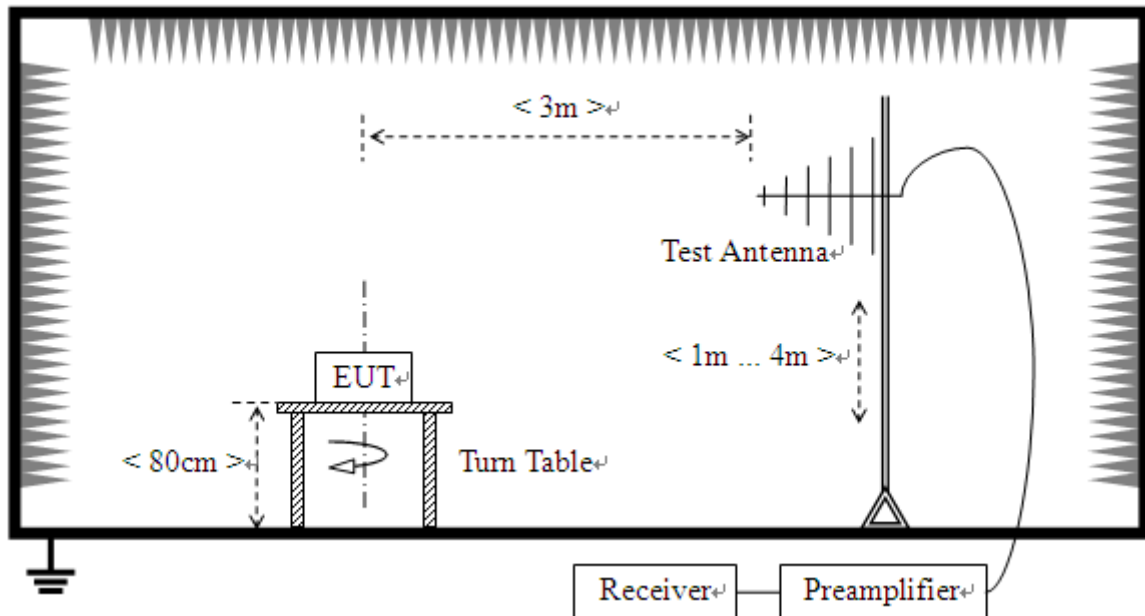
B. Equipments List:

Description	Manufacturer	Model	Serial No.	Calibration Date	Calibration Due. Date
Test Receiver	ROHDE&SCHWARZ	ESCI	A130901475	2014.09.09	2015.09.08
LISN	ROHDE&SCHWARZ	ENV216	/	2014.04.28	2015.04.27
Cable	MATCHING PAD	W7	/	2014.06.05	2015.06.04

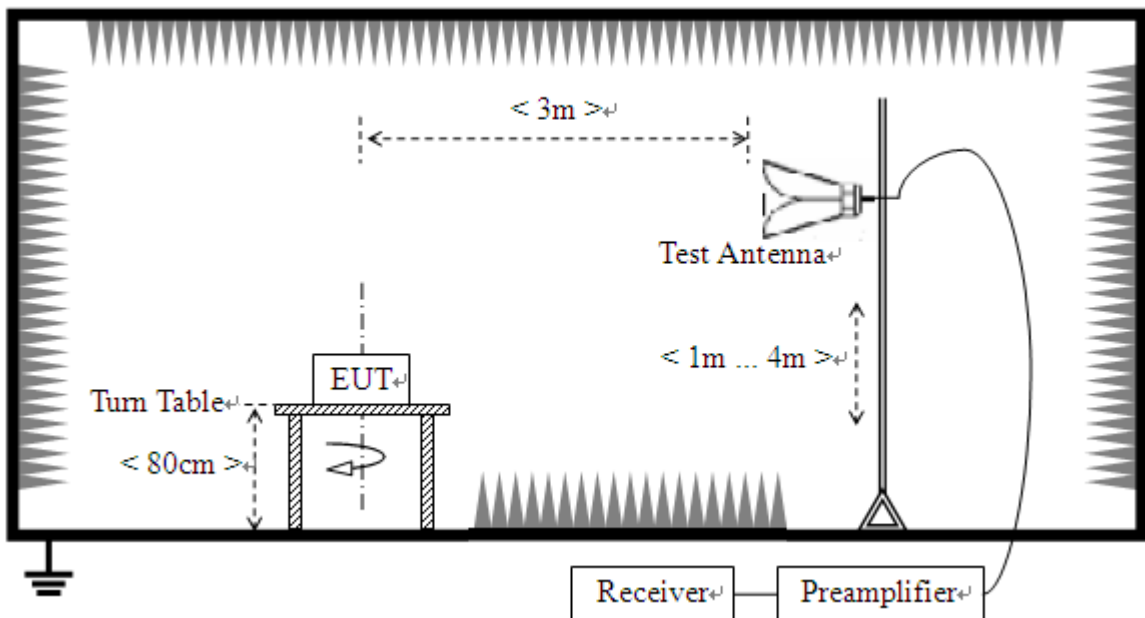
2.3.2 Radiated Emission

A. Test Setup:

- 1) For radiated emissions from 30MHz to 1GHz



- 2) For radiated emissions above 1GHz



B. Test Procedure

The test is performed in a 3m Semi-Anechoic Chamber; the antenna factor, cable loss and so on of the site (factors) is calculated to correct the reading. The EUT is placed on a 0.8m high insulating Turn Table, and keeps 3m away from the Test Antenna, which is mounted on a

variable-height antenna master tower.

For the test Antenna:

- 1) In the frequency range above 30MHz, Bi-Log Test Antenna (30MHz to 1GHz) and Horn Test Antenna (above 1GHz) are used. Test Antenna is 3m away from the EUT. Test Antenna height is varied from 1m to 4m above the ground to determine the maximum value of the field strength. The emission levels at both horizontal and vertical polarizations should be tested.

C. Equipments List:

Description	Manufacturer	Model	Serial No.	Calibration Date	Calibration Due. Date
Test Receiver	ROHDE&SCHWARZ	ESIB7	A0501375	2014.06.10	2015.06.09
Test Receiver	ROHDE&SCHWARZ	ESIB26	A0304218	2014.06.10	2015.06.09
Semi-Anechoic Chamber	Albatross	9m*6m*6m	A0412372	2015.03.22	2016.03.21
Test Antenna - Bi-Log	HP	CBL6111A	A9704202	2014.06.10	2015.06.09
Test Antenna – Horn	ROHDE&SCHWARZ	HF906	A0304225	2014.06.10	2015.06.09
Anechoic Chamber	Albatross	SAC-5MAC 12.8x6.8x6.4m	A0304210	2015.03.22	2016.03.21
Amplifier 1G~18GHz	ROHDE&SCHWARZ	MITEQ AFS42-001018 00	A0509366	2014.06.10	2015.06.09
Amplifier 20M~3GHz	Compliance Direction System	PAP-0203H	A0509377	2014.06.10	2015.06.09
Cable	SUNHNER	SUCOFLEX 100	/	2014.06.10	2015.06.09
Cable	SUNHNER	SUCOFLEX 104	MY1758/4	2014.06.10	2015.06.09

3. 47 CFR PART 15B REQUIREMENTS

3.1 Conducted Emission

3.1.1 Requirement

According to FCC section 15.107, the radio frequency voltage that is conducted back onto the AC power line on any frequency within the band 150kHz to 30MHz shall not exceed the limits in the following table, as measured using a 50 μ H/50 Ω line impedance stabilization network (LISN).

Frequency range (MHz)	Conducted Limit (dB μ V)	
	Quasi-peak	Average
0.15 - 0.50	66 to 56	56 to 46
0.50 - 5	56	46
5 - 30	60	50

NOTE:

- The limit subjects to the Class B digital device.
- The lower limit shall apply at the band edges.
- The limit decreases linearly with the logarithm of the frequency in the range 0.15 - 0.50MHz.

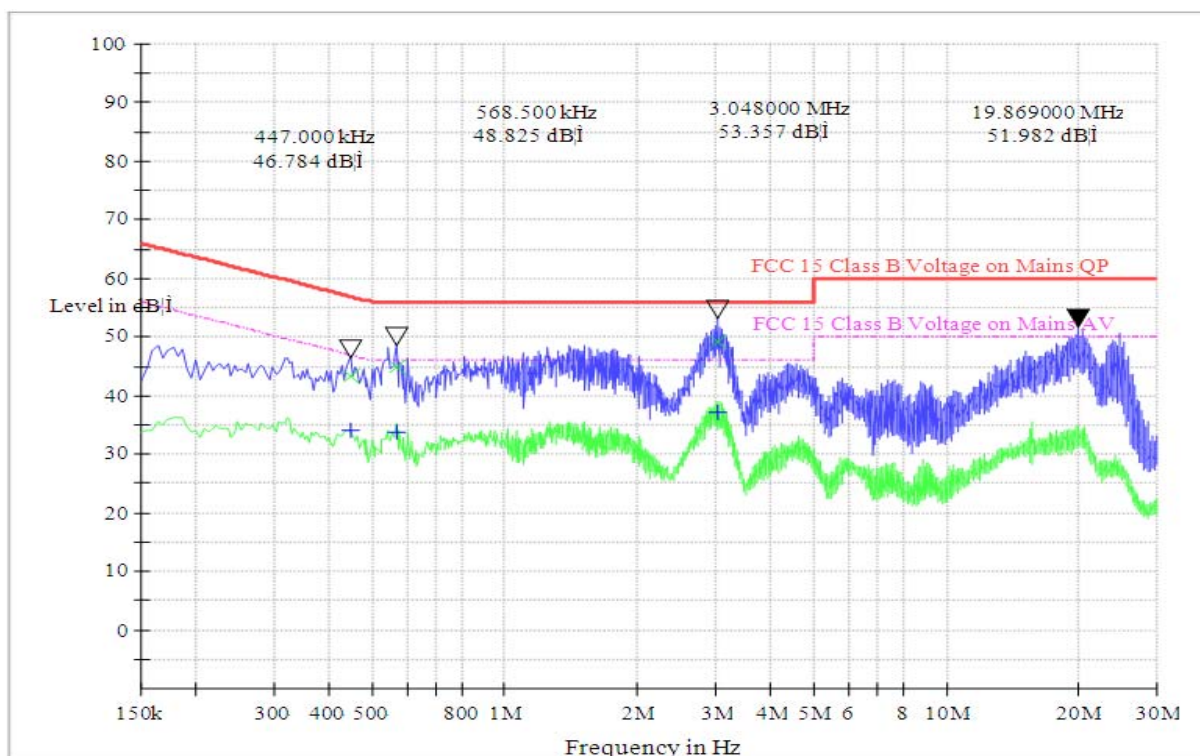
3.1.2 Test Description

See section 2.3.1 of this report.

3.1.3 Test Result

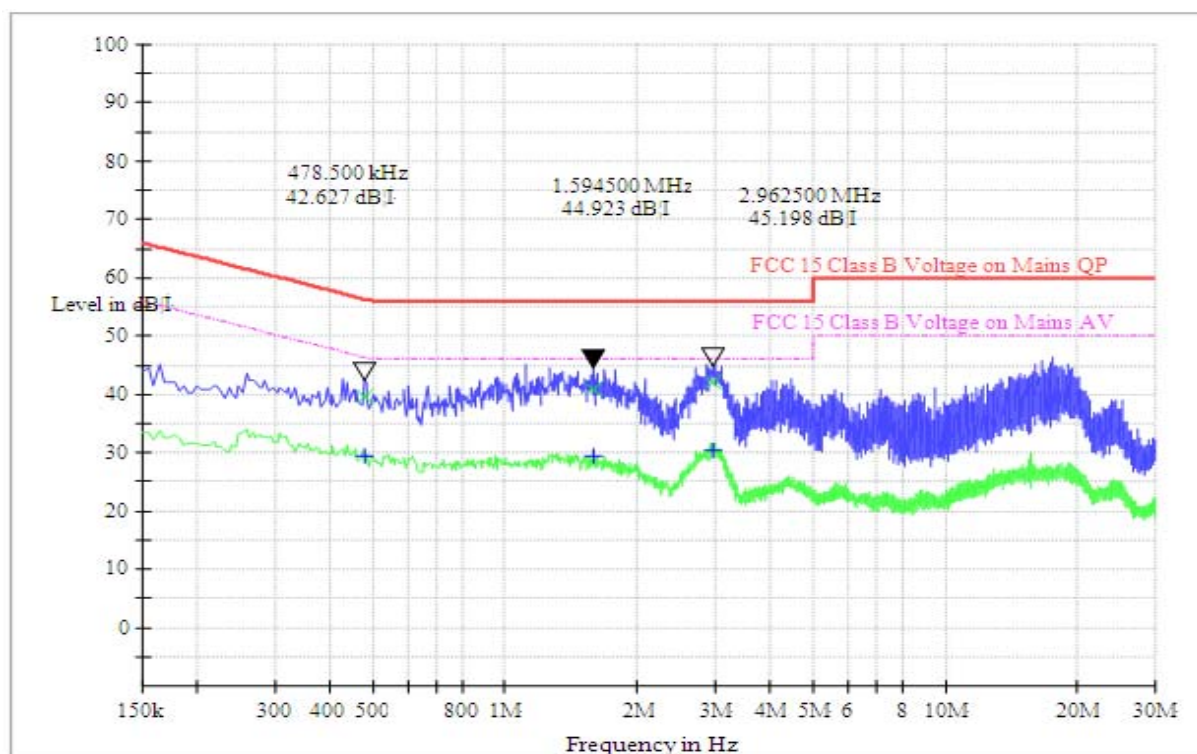
The maximum conducted interference is searched using Peak (PK), Quasi-peak (QP) and Average (AV) detectors; the emission levels more than the AV and QP limits, and that have narrow margins from the AV and QP limits will be re-measured with AV and QP detectors. Tests for both L phase and N phase lines of the power mains connected to the EUT are performed. All test modes are considered, refer to recorded points and plots below.

A. Test Plot and Suspicious Points:



(Plot A: L Phase)

Conducted Disturbance at Mains Terminals							
L Test Data							
QP				AV			
Frequency (MHz)	Limits (dBμV)	Measurement Value (dBμV)	Margin (dB)	Frequency (MHz)	Limits (dBμV)	Measurement Value (dBμV)	Margin (dB)
0.4470	56.90	43.37	13.53	0.4470	46.90	33.91	12.99
0.5685	56.00	44.73	11.27	0.5685	46.00	33.80	12.20
3.0480	56.00	51.21	4.79	3.0480	46.00	36.99	9.01



(Plot B: N Phase)

Conducted Disturbance at Mains Terminals							
N Test Data							
QP				AV			
Frequency (MHz)	Limits (dBμV)	Measurement Value (dBμV)	Margin (dB)	Frequency (MHz)	Limits (dBμV)	Measurement Value (dBμV)	Margin (dB)
0.4785	56.40	39.71	16.69	0.4785	46.40	29.51	16.89
1.5945	56.00	40.92	15.08	1.5945	46.00	29.51	16.49
2.9625	56.00	42.17	13.83	2.9625	46.00	30.33	15.67

Test Result: PASS

3.2 Radiated Emission

3.2.1 Requirement

According to FCC section 15.109, the field strength of radiated emissions from unintentional radiators at a distance of 3 meters shall not exceed the following values:

Radiated Emissions Limits below 1GHz

Frequency range (MHz)	ClassB Radiated Limit (dB μ V/m)
	Quasi-peak
30 to 88	40
88 to 216	43.5
216 to 960	46
960 to 1000	54

Radiated Emissions Limits above 1GHz

Frequency range (MHz)	ClassB Radiated Limit (dB μ V/m)	
	Linear Average Detector	Peak Detector
>1000	54	74

- As shown in FCC section 15.35(b), for frequencies above 1000MHz, the field strength limits are based on average detector. When average radiated emission measurements are specified in this part, including emission measurements below 1000MHz, there also is a limit on the radio frequency emissions, as measured using instrumentation with a peak detector function, corresponding to 20dB above the maximum permitted average limit for the frequency being investigated unless a different peak emission limit is otherwise specified in the rules.
- Test Antenna is 3m away from the EUT. Test Antenna height is varied from 1m to 4m above the ground to determine the maximum value of the field strength.
- For below 1G :QP detector RBW 120kHz ,VBW 300kHz.
- For Above 1G: PK detector RBW 1MHz,VBW 3MHz for PK value ;PK detector RBW 1MHz, VBW 10Hz for AV value.

Note:

- The tighter limit shall apply at the boundary between two frequency range.
- Limitation expressed in dB μ V/m is calculated by $20\log$ Emission Level(μ V/m).
- If measurement is made at 3m distance, then F.S Limitation at 3m distance is adjusted by using the formula of $Ld1 = Ld2 * (d2/d1)^2$.

Example:

F.S Limit at 30m distance is 30 μ V/m, then F.S Limitation at 3m distance is adjusted as

$$Ld1 = L1 = 30\mu\text{V/m} * (10)^2 = 100 * 30\mu\text{V/m}.$$

3.2.2 Test Description

See section 2.3.2 of this report.

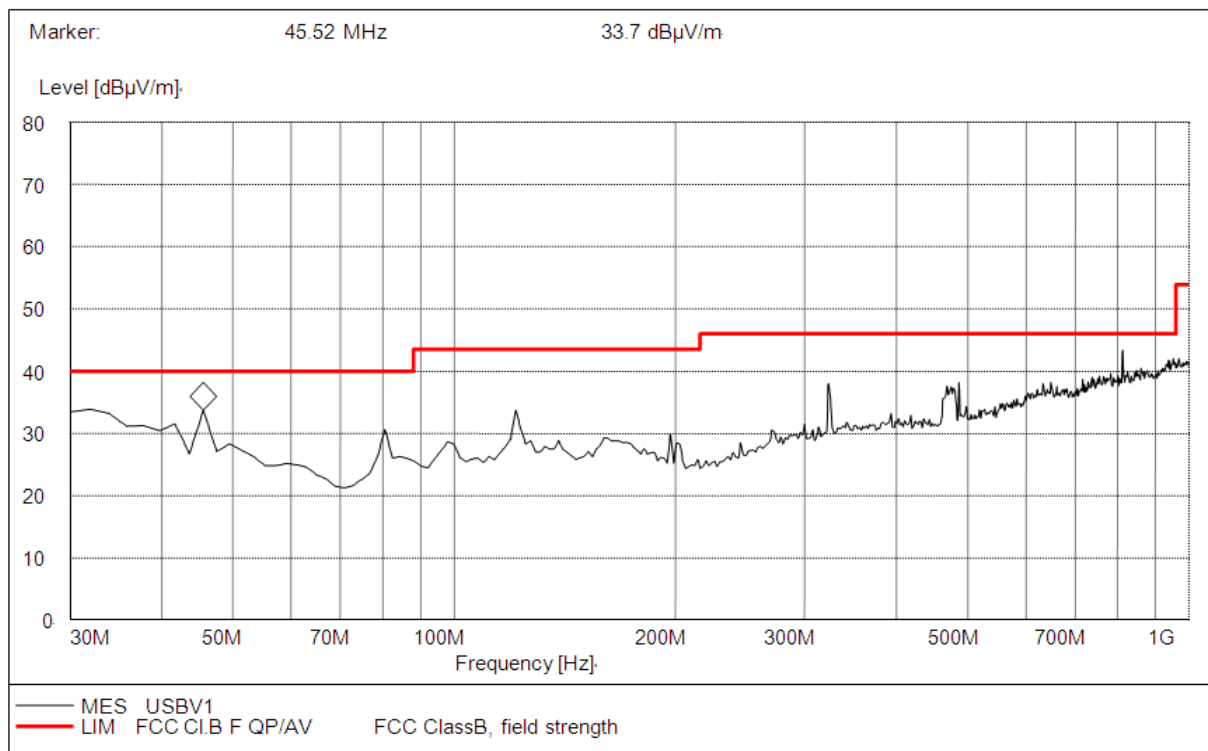
3.2.3 Test Result

The maximum radiated emission is searched using PK, QP and AV detectors; the emission levels more than the limits, and that have narrow margins from the limits will be re-measured with AV and QP detectors. Both the vertical and the horizontal polarizations of the Test Antenna are considered to perform the tests. All test modes are considered, refer to recorded points and plots below.

The amplitude of spurious emissions which are attenuated more than 20 dB below the permissible value need not be reported.

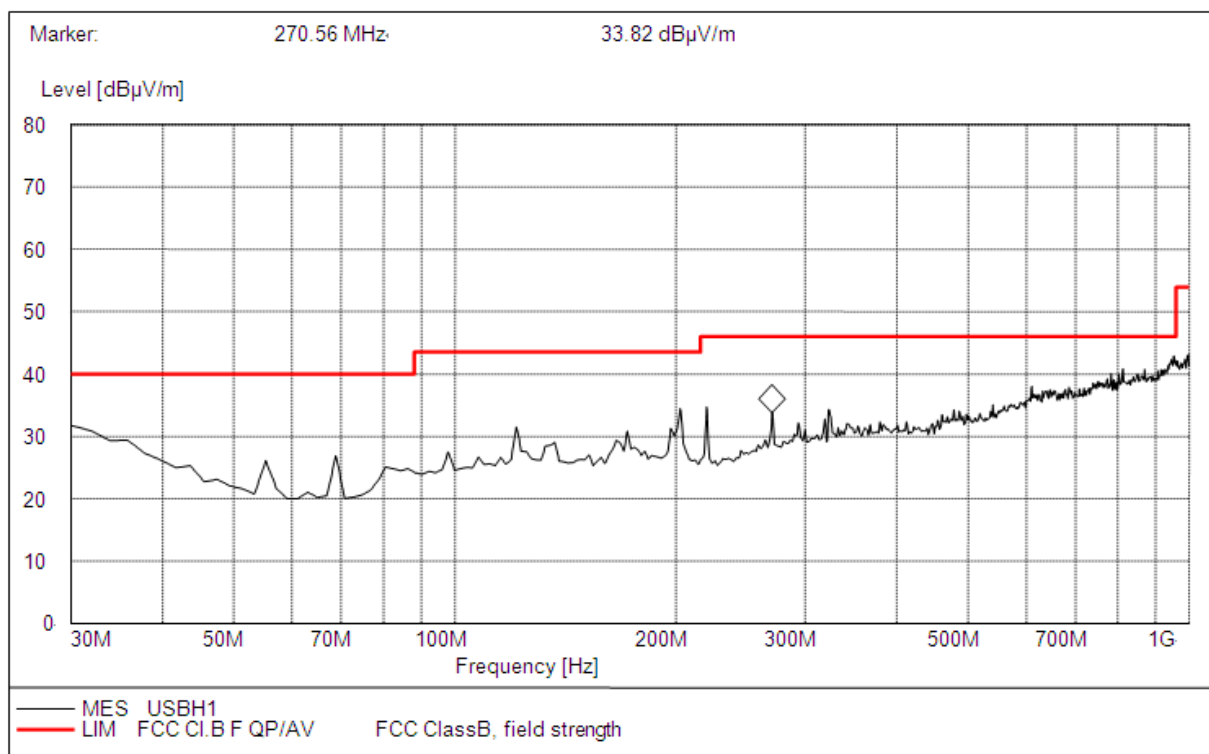
Note: All radiated emission tests were performed in X, Y, Z axis direction, and only the worst axis test condition was recorded in this test report.

B. Test Plots and Suspicious Points:



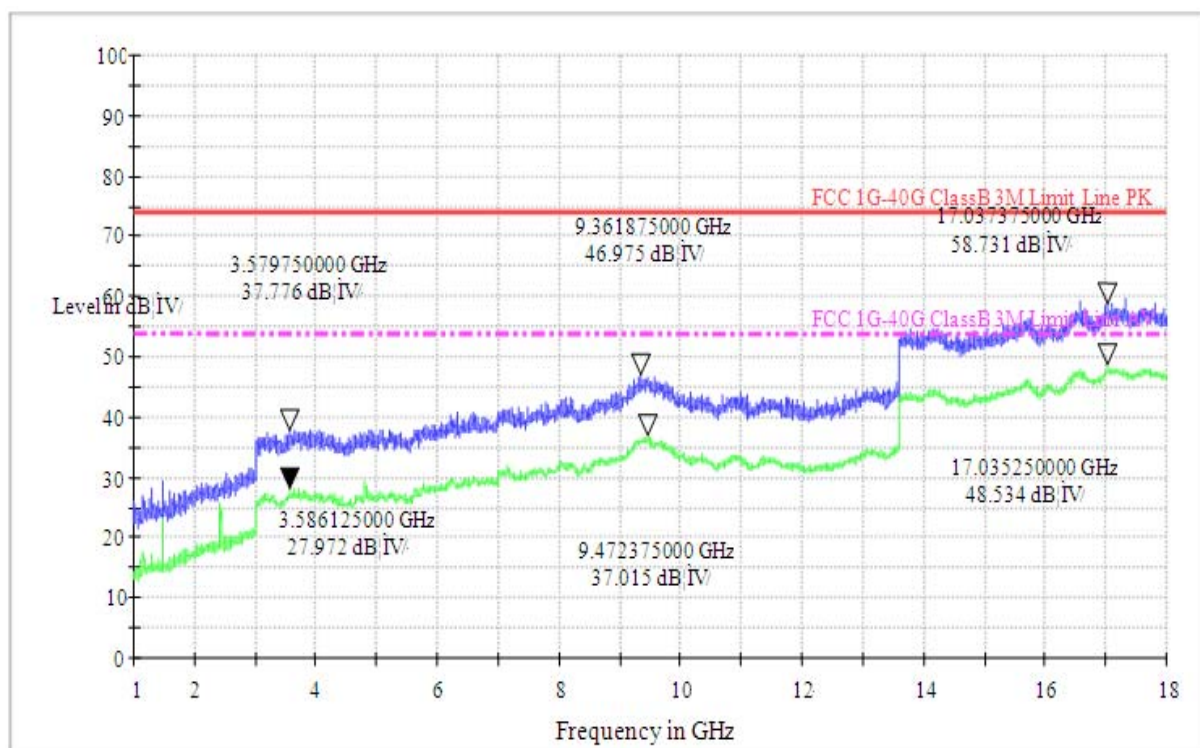
(Plot C: Test Antenna Vertical 30M - 1G)

Frequency (MHz)	QuasiPeak (dB μ V/m)	Bandwidth (kHz)	Antenna height (cm)	Limit (dB μ V/m)	Margin (dB)	Antenna	Verdict
45.36000	31.27	120.000	130.0	40.00	8.73	Vertical	Pass
121.36000	31.06	120.000	200.0	43.50	12.44	Vertical	Pass
485.36000	37.15	120.000	150.0	46.00	8.85	Vertical	Pass



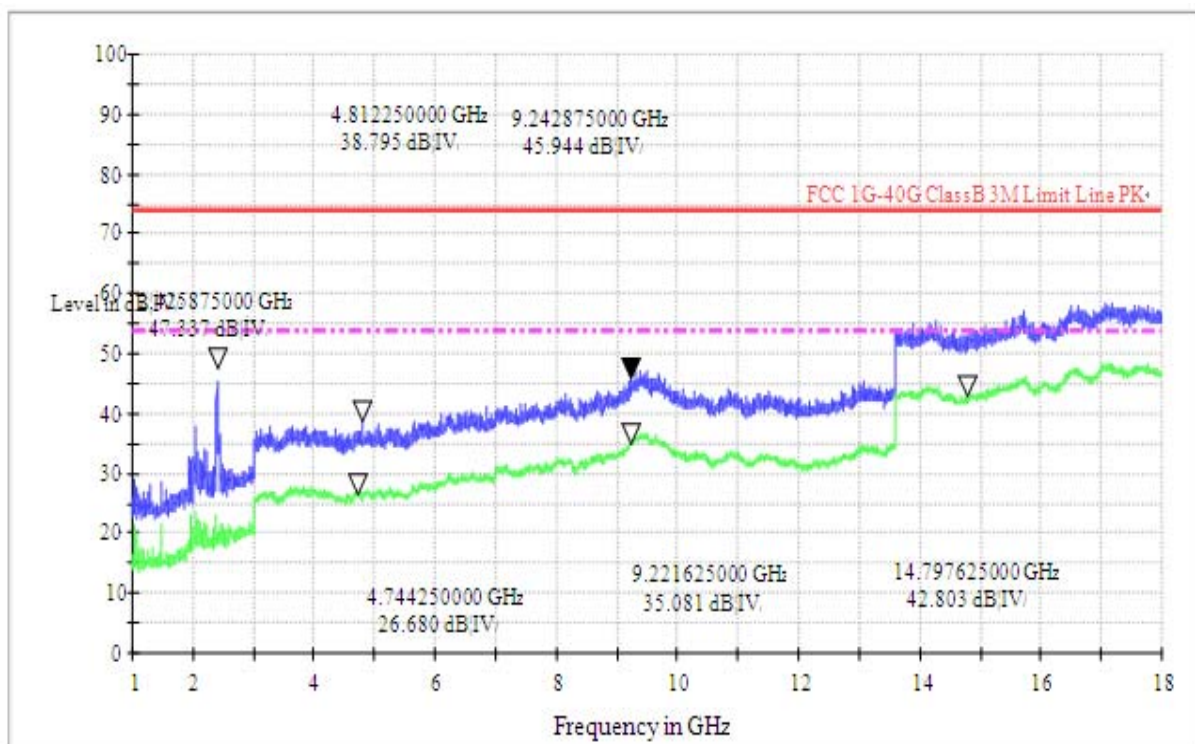
(Plot D:Test Antenna Horizontal 30M - 1G)

Frequency (MHz)	QuasiPeak (dB μ V/m)	Bandwidth (kHz)	Antenna height (cm)	Limit (dB μ V/m)	Margin (dB)	Antenna	Verdict
121.36000	32.65	120.000	130.0	43.50	10.85	Horizontal	Pass
202.36000	32.59	120.000	145.0	43.50	10.91	Horizontal	Pass
270.52000	32.34	120.000	180.0	46.00	13.66	Horizontal	Pass



(Plot E: Test Antenna Horizontal 1G – 18G)

Frequency (MHz)	PK/AV (dB μ V/m)	Bandwidth (kHz)	Antenna height (cm)	Limit (dB μ V/m)	Margin (dB)	Antenna	Verdict
3586.75000	26.76	1000.000	150.0	54.00	27.24	Horizontal	Pass
9472.30000	36.89	1000.000	150.0	54.00	17.11	Horizontal	Pass
17035.0000	47.25	1000.000	200.0	54.00	6.75	Horizontal	Pass
3579.20000	36.68	1000.000	200.0	74.00	37.32	Horizontal	Pass
9361.50000	44.93	1000.000	150.0	74.00	29.07	Horizontal	Pass
17036.3000	56.71	1000.000	150.0	74.00	17.29	Horizontal	Pass



(Plot F: Test Antenna Vertical 1G – 18G)

Frequency (MHz)	PK/AV (dBμV/m)	Bandwidth (kHz)	Antenna height (cm)	Limit (dBμV/m)	Margin (dB)	Antenna	Verdict
4744.26000	26.20	1000.000	175.0	54.00	27.80	Vertical	Pass
9220.36000	34.66	1000.000	150.0	54.00	19.34	Vertical	Pass
14796.2500	42.28	1000.000	100.0	54.00	11.72	Vertical	Pass
2425.60000	45.26	1000.000	150.0	74.00	28.74	Vertical	Pass
4812.30000	37.69	1000.000	205.0	74.00	36.31	Vertical	Pass
9242.80000	44.36	1000.000	150.0	74.00	29.64	Vertical	Pass

Test Result: PASS

**** END OF REPORT ****